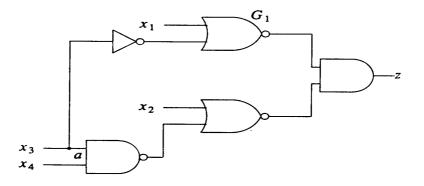
## Name:

## COE 464, Term 042 Testing of Digital Circuits

## Quiz#1

Date: Sunday, Feb. 27, 2005

**Q1.** Consider the circuit given below:



- i. Find a Boolean expression for the set of all tests that detect the fault  $x_3$  s-a-0.
- ii. Mark on the circuit all the possible **single stuck-at faults** using the symbol **s0** for stuck-at-0 faults and the symbol **s1** for stuck-at-1 faults.
- iii. Mark on the circuit all the single stuck-at faults that can be eliminated due to Fault Equivalence relation by drawing a <u>circuit</u> around them.
- iv. Mark on the circuit all the single stuck-at faults that can be eliminated due to Fault Dominance relation by drawing a square around them.